An Automatic Grader for Embedded Systems Projects

by Daniel Mendelsohn MIT S.B., 2015

Submitted to the Department of Electrical Engineering and Computer Science in Partial Fulfillment of the Requirements for the Degree of

Master of Engineering in Electrical Engineering and Computer Science

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ABSTRACT

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1 Introduction

2 Prior Work

3 Design Principles

4 Implementation

5 Automatic Test Generation

6 Results

7 Future Work